Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination NOWAK, FRANZ-MARCUS	
09/835,257		
Examiner	Art Unit	
Tai T. Nguyen	2612	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
340	286.02 384.1 309.15 309.4 601	1/16/2007	TN
368	10 12 13	1/16/2007	TN
368	73	1/16/2007	TN

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH A	AS ABOVE	1/16/2007	TN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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